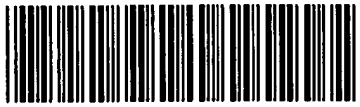


<b>Search Notes</b>  	<b>Application/Control No.</b>  10706445	<b>Applicant(s)/Patent Under Reexamination</b>  SHINKAI ET AL.
	<b>Examiner</b>  tWendmagegn, Girumsew	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
386	52	2/13/2008	gw
725	115	2/13/2008	gw
725	93	2/13/2008	gw
725	145	2/13/2008	gw

SEARCH NOTES		
Search Notes	Date	Examiner
US-PGPUB;USPAT;USOCR;EPO;JPO;DERWENT;IBM_TDB	2/7/2008	gw
Inventor(s) search	2/13/2008	gw
NPL: google( metadata WITH editing)	6/22/2007	gw

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner